

Notic of Ref rences Cit d

Application/Control No.

10/052,487

Applicant(s)/Patent Under

Reexamination

FREIER ET AL.

Examiner

Deborah Yee

Art Unit

1742

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,584,035	04-1986	Arai et al	148/320
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	V	
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